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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Hiroki MOURI, et al. Art Unit : Unknown
Serial No. : 10/587,080 Examiner : Unknown
Filing Date: July 21, 2006
Title : SIGNAL PROCESSING DEVICE AND SIGNAL PROCESSING
METHOD

INFORMATION DISCLOSURE STATEMENT

Customer Window
U.S. Patent & Trademark Office
Randolph Building
401 Dulany St.
Alexandria, Virginia 22314

Sir:

Pursuant to 37 C.F.R. 1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached Form PTO-1449. Copies of the references listed on Form PTO-1449 are attached.

Also enclosed is a copy of the International Search Report for the corresponding PCT application. The USPTO is directed thereto for a concise statement of possible relevance of the references cited therein.

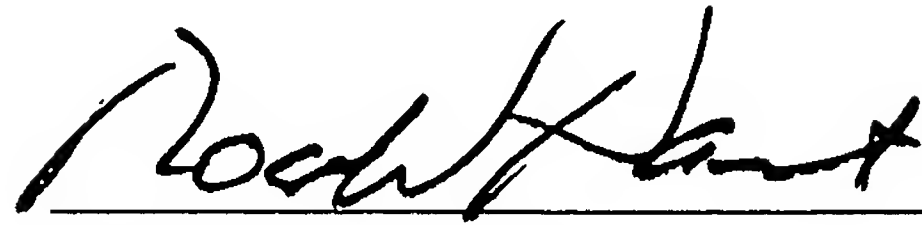
The above information is presented so that the Patent and Trademark Office may, in the first instance, determine any materiality thereof to the claimed invention. See 37 C.F.R. 1.104(a) and 1.106(b) concerning the PTO duty to consider and use any such information. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that this reference be made of record therein and appear among the "References

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Cited" on any patent to issue therefrom.

Respectfully submitted,

STEPTOE & JOHNSON LLP



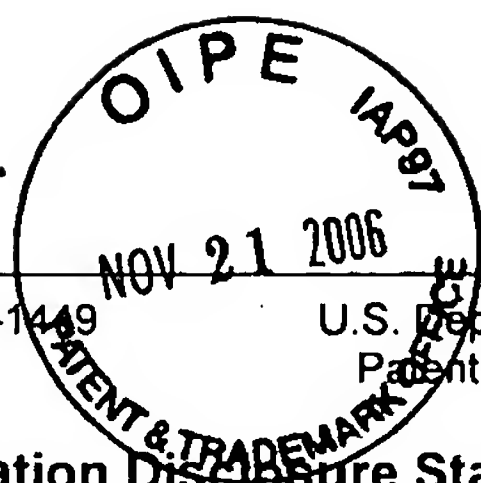
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November 21, 2006
Date

RWP/lmw

Attorney Docket No.: 28951.1181

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Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 28951.1181	Application No. 10/587,080
	Applicant Hiroki MOURI, et al.		
	Filing Date 07/21/2006	Group Art Unit Unknown	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	US2002/0159350 A1	10/31/2002	Ogura, et al.			
	AB	US2003/0169665 A1	09/11/2003	Miyashita			

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AC	1 126 456 A2	08/22/2001	EPO				
	AD	11339395 A	12/10/1999	Japan			Abstract	
	AE	2000243034 A	09/08/2000	Japan			Abstract	
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	AG	2001-297534	10/26/2001	Japan				X
	AH	2002343023 A	11/29/2002	Japan			Abstract	
	AI	2003-85764	03/20/2003	Japan				X
	AJ							
	AK							
	AL							
	AM							
	AN							
	AO							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AP	
	AQ	

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	